

BFR460L3

Low profile silicon NPN RF bipolar transistor



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Technical documents



Simulation



Support

Product description

The BFR460L3 is a low noise device based on a grounded emitter (SIEGET™) that is part of Infineon's established fourth generation RF bipolar transistor family. Its transition frequency f_T of 22 GHz, low current and low voltage characteristics make the device suitable for amplifiers. It remains cost competitive without compromising on ease of use.



Feature list

- Minimum noise figure $NF_{min} = 1.1$ dB at 1.8 GHz, 3 V, 5 mA
- High gain $G_{ms} = 16$ dB at 1.8 GHz, 3 V, 20 mA
- $OIP_3 = 27$ dBm at 1.8 GHz, 3 V, 20 mA
- High ESD performance, typical value 1.5 kV (HBM)

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Potential applications

- Amplifier for remote keyless entry (RKE)
- Broadband low noise amplifiers (LNAs) for CATV, DVB-T, DAB/DMB and FM/AM radio
- LNAs for sub-1 GHz ISM band applications

Device information

Table 1 Part information

| Product name / Ordering code | Package | Pin configuration | | | Marking | Pieces / Reel |
|-------------------------------|----------|-------------------|-------|-------|---------|---------------|
| BFR460L3 / BFR460L3E6327XTMA1 | TSLP-3-1 | 1 = B | 2 = E | 3 = C | AB | 15000 |

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

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Absolute maximum ratings

1 Absolute maximum ratings

Table 2 Absolute maximum ratings at $T_A = 25\text{ °C}$ (unless otherwise specified)

| Parameter | Symbol | Values | | Unit | Note or test condition |
|---------------------------------------|-----------|--------|------|------|-----------------------------------|
| | | Min. | Max. | | |
| Collector emitter voltage | V_{CEO} | - | 4.5 | V | Open base |
| | | | 4.2 | | $T_A = -55\text{ °C}$, open base |
| Collector emitter voltage | V_{CES} | | 15 | | E-B short circuited |
| Collector base voltage | V_{CBO} | | 15 | | Open emitter |
| Emitter base voltage | V_{EBO} | | 1.5 | | Open collector |
| Base current | I_B | | 5 | mA | - |
| Collector current | I_C | | 50 | | |
| Total power dissipation ¹⁾ | P_{tot} | | 200 | mW | $T_S \leq 108\text{ °C}$ |
| Junction temperature | T_J | | 150 | °C | |
| Storage temperature | T_{Stg} | -55 | | | |

Attention: *Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the integrated circuit.*

¹ T_S is the soldering point temperature. T_S is measured on the emitter lead at the soldering point of the PCB.

Thermal characteristics

2 Thermal characteristics

Table 3 Thermal resistance

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|----------------------------|------------|--------|------|------|------|------------------------|
| | | Min. | Typ. | Max. | | |
| Junction - soldering point | R_{thJS} | - | 210 | - | K/W | - |

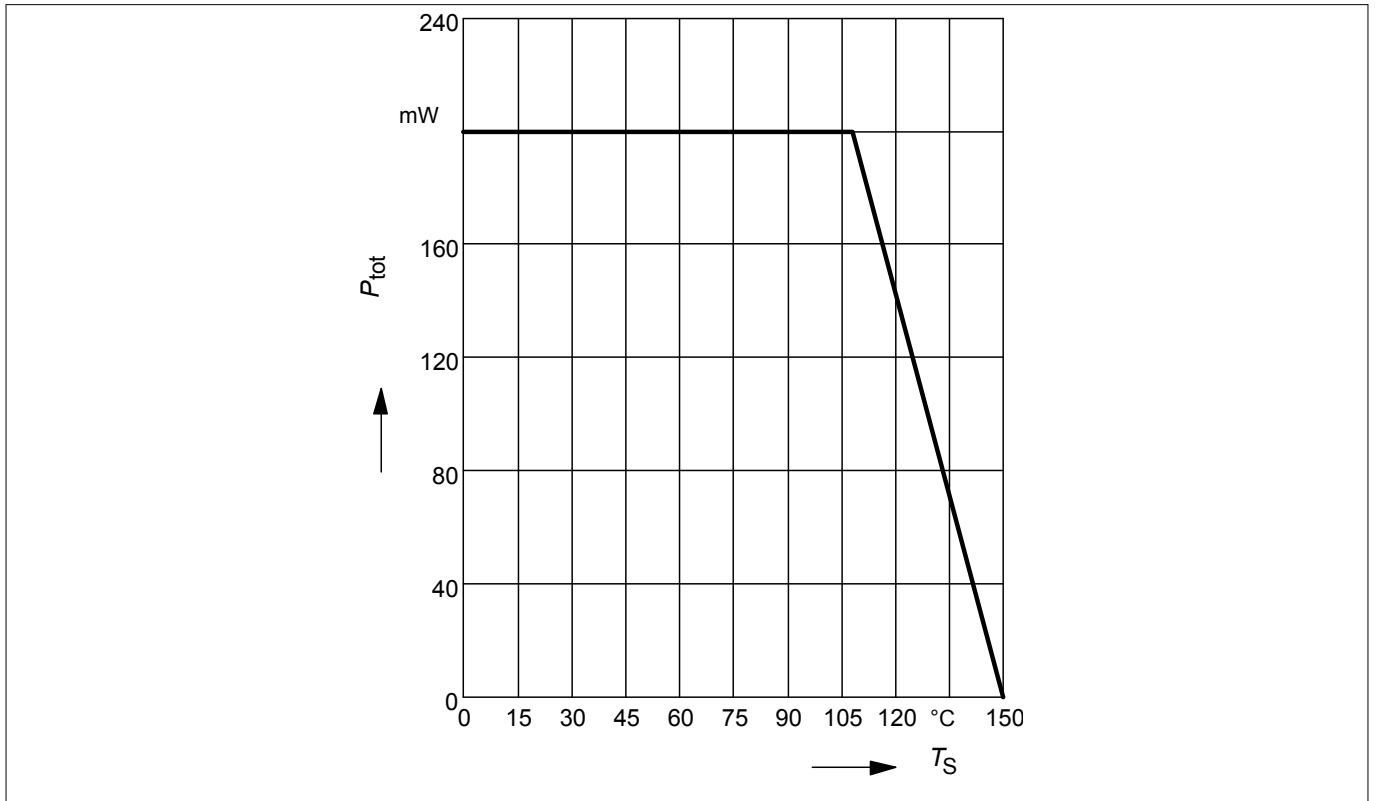


Figure 1 Total power dissipation $P_{tot} = f(T_s)$

Electrical characteristics

3 Electrical characteristics

3.1 DC characteristics

Table 4 DC characteristics at $T_A = 25^\circ\text{C}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|-------------------------------------|---------------|--------|------|-------------------|---------------|---|
| | | Min. | Typ. | Max. | | |
| Collector emitter breakdown voltage | $V_{(BR)CEO}$ | 4.5 | 5.8 | – | V | $I_C = 1\text{ mA}$, $I_B = 0$, open base |
| Collector emitter leakage current | I_{CES} | – | – | 10 ²⁾ | μA | $V_{CE} = 15\text{ V}$, $V_{BE} = 0$, E-B short circuited |
| Collector base leakage current | I_{CBO} | | | 100 ²⁾ | nA | $V_{CB} = 5\text{ V}$, $I_E = 0$, open emitter |
| Emitter base leakage current | I_{EBO} | | | 1 ²⁾ | μA | $V_{EB} = 0.5\text{ V}$, $I_C = 0$, open collector |
| DC current gain | h_{FE} | 90 | 120 | 160 | | $V_{CE} = 3\text{ V}$, $I_C = 20\text{ mA}$, pulse measured |

3.2 General AC characteristics

Table 5 General AC characteristics at $T_A = 25^\circ\text{C}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|-------------------------------|----------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Transition frequency | f_T | 16 | 22 | – | GHz | $V_{CE} = 3\text{ V}$, $I_C = 30\text{ mA}$, $f = 1\text{ GHz}$ |
| Collector base capacitance | C_{CB} | – | 0.28 | 0.45 | pF | $V_{CB} = 3\text{ V}$, $V_{BE} = 0$, $f = 1\text{ MHz}$, emitter grounded |
| Collector emitter capacitance | C_{CE} | | 0.14 | – | | $V_{CE} = 3\text{ V}$, $V_{BE} = 0$, $f = 1\text{ MHz}$, base grounded |
| Emitter base capacitance | C_{EB} | | 0.55 | | | $V_{EB} = 0.5\text{ V}$, $V_{CB} = 0$, $f = 1\text{ MHz}$, collector grounded |

² Maximum values not limited by the device but by the short cycle time of the 100% test.

Electrical characteristics

3.3 Frequency dependent AC characteristics

Measurement setup is a test fixture with Bias T's in a 50 Ω system, $T_A = 25\text{ °C}$.

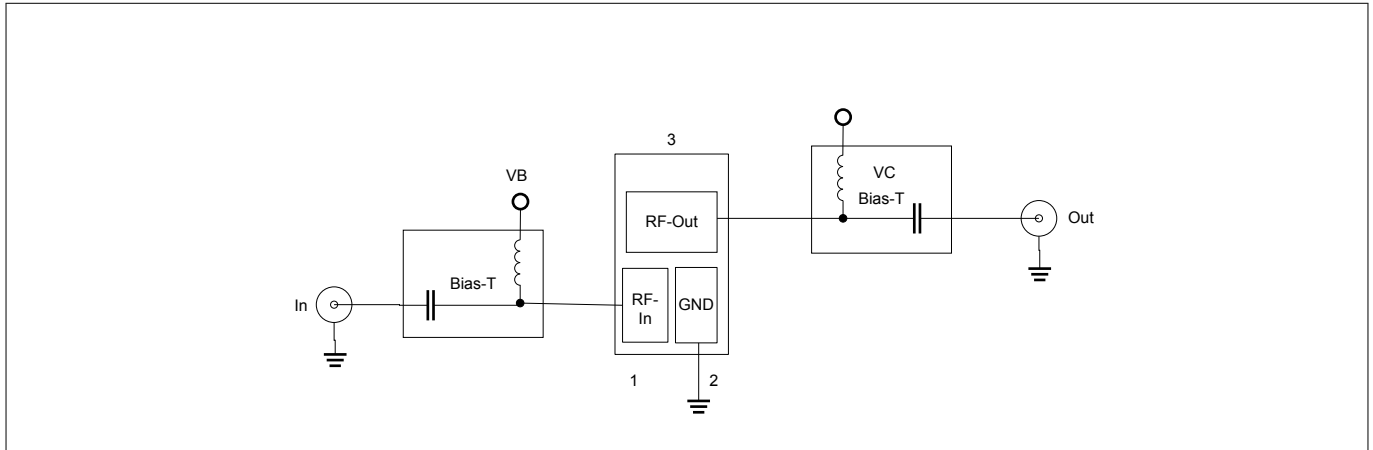


Figure 2 Testing circuit

Table 6 AC characteristics, $V_{CE} = 3\text{ V}$, $f = 1.8\text{ GHz}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|---|--------------------------|--------|----------------|------|------|---|
| | | Min. | Typ. | Max. | | |
| Power gain | | - | | - | dB | $I_C = 20\text{ mA}$ |
| <ul style="list-style-type: none"> Maximum power gain Transducer gain | G_{ms} $ S_{21} ^2$ | | 16 14 | | | |
| Noise figure | | | | | | |
| <ul style="list-style-type: none"> Minimum noise figure | NF_{min} | | 1.1 | | | $I_C = 5\text{ mA}$ |
| Linearity | | | | | dBm | $Z_S = Z_L = 50\text{ }\Omega$, $I_C = 20\text{ mA}$ |
| <ul style="list-style-type: none"> 3rd order intercept point at output 1 dB compression point at output | OIP_3 OP_{1dB} | | 27 11.5 | | | |

Table 7 AC characteristics, $V_{CE} = 3\text{ V}$, $f = 3\text{ GHz}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|---|--------------------------|--------|--------------|------|------|------------------------|
| | | Min. | Typ. | Max. | | |
| Power gain | | - | | - | dB | $I_C = 20\text{ mA}$ |
| <ul style="list-style-type: none"> Maximum power gain Transducer gain | G_{ma} $ S_{21} ^2$ | | 11 10 | | | |
| Noise figure | | | | | | |
| <ul style="list-style-type: none"> Minimum noise figure | NF_{min} | | 1.35 | | | $I_C = 5\text{ mA}$ |

Note: $G_{ms} = |S_{21} / S_{12}|$ for $k < 1$; $G_{ma} = |S_{21} / S_{12}| (k - (k^2 - 1)^{1/2})$ for $k > 1$. In order to get the NF_{min} values stated in this chapter, the test fixture losses have been subtracted from all measured results. OIP_3 value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.2 MHz to 12 GHz.

Electrical characteristics

3.4 Characteristic AC diagrams

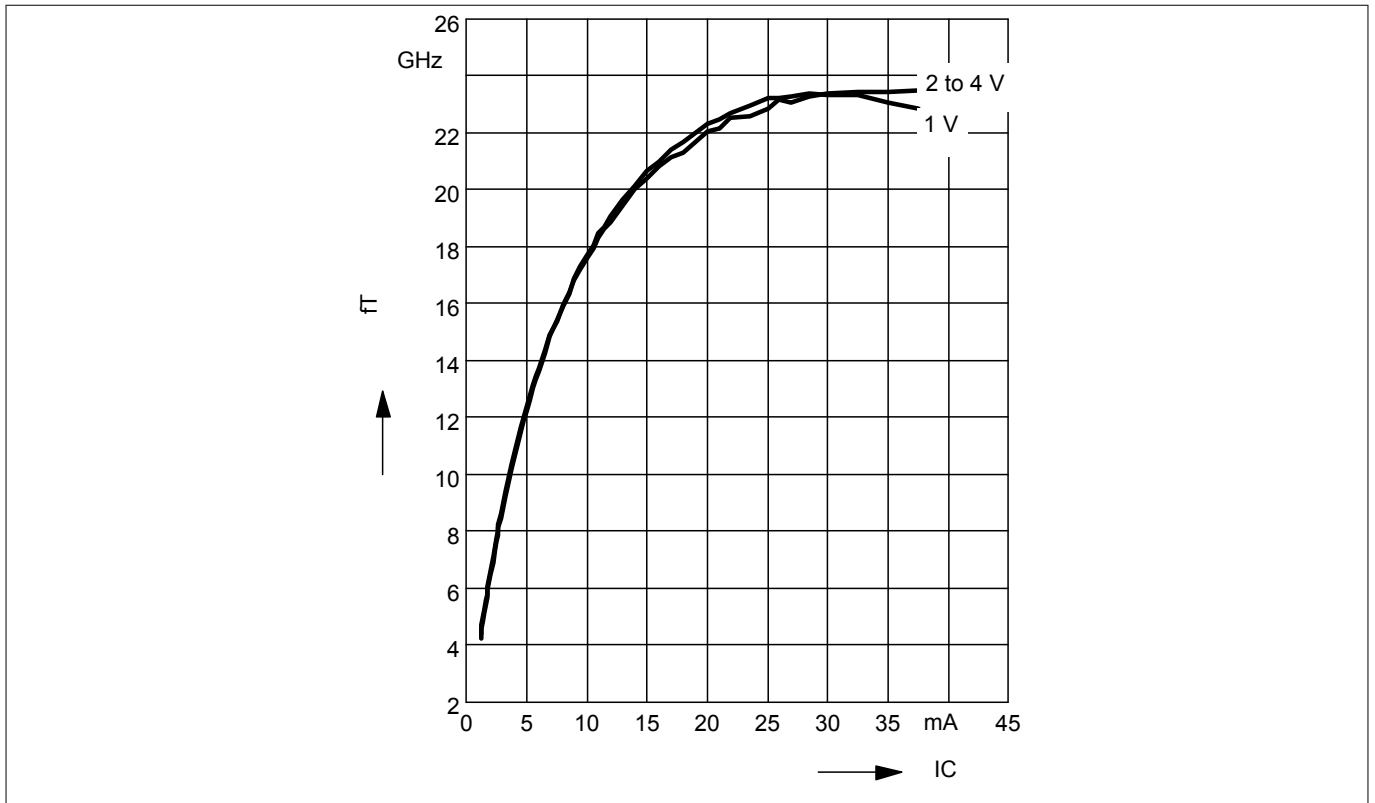


Figure 3 Transition frequency $f_T = f(I_C)$, $f = 1$ GHz, $V_{CE} = \text{parameter}$

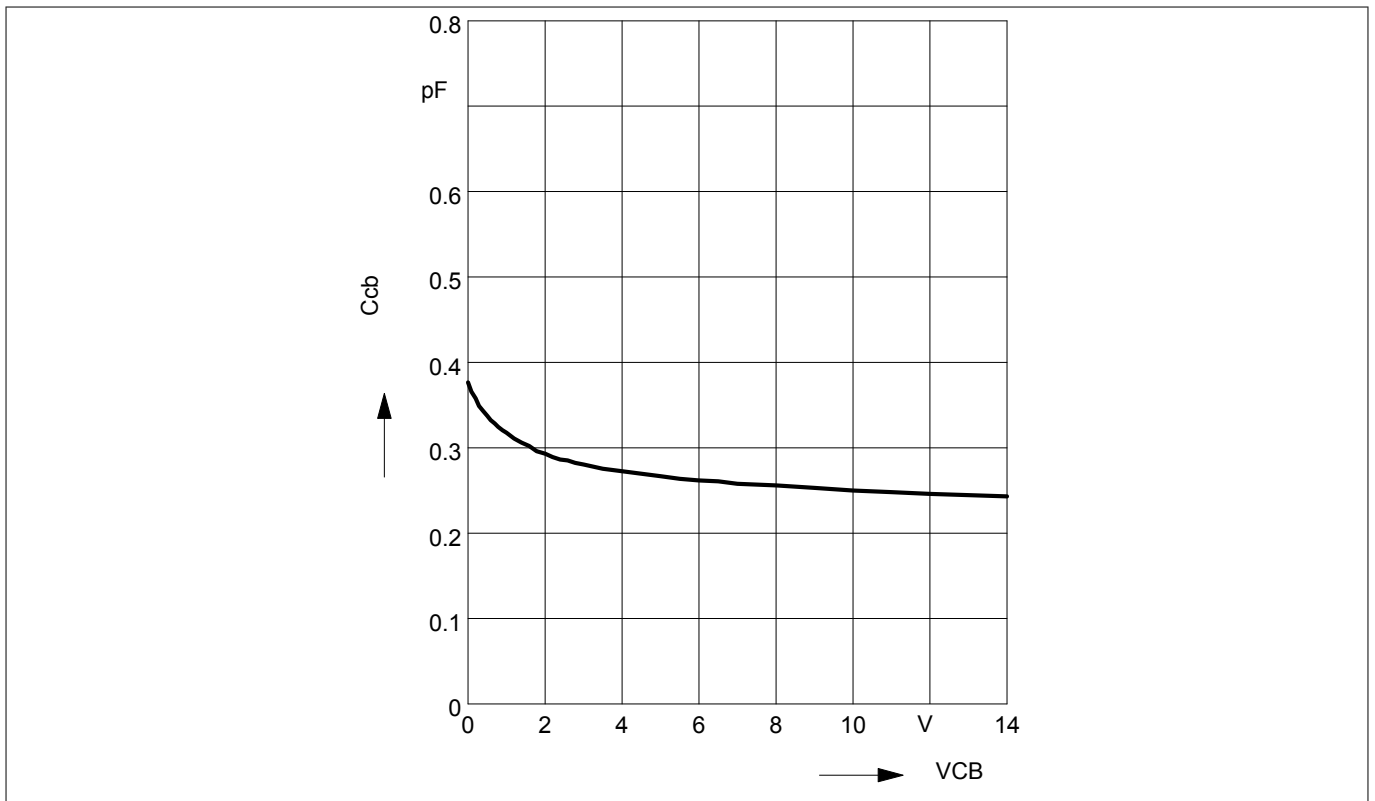


Figure 4 Collector base capacitance $C_{CB} = f(V_{CB})$, $f = 1$ MHz

Electrical characteristics

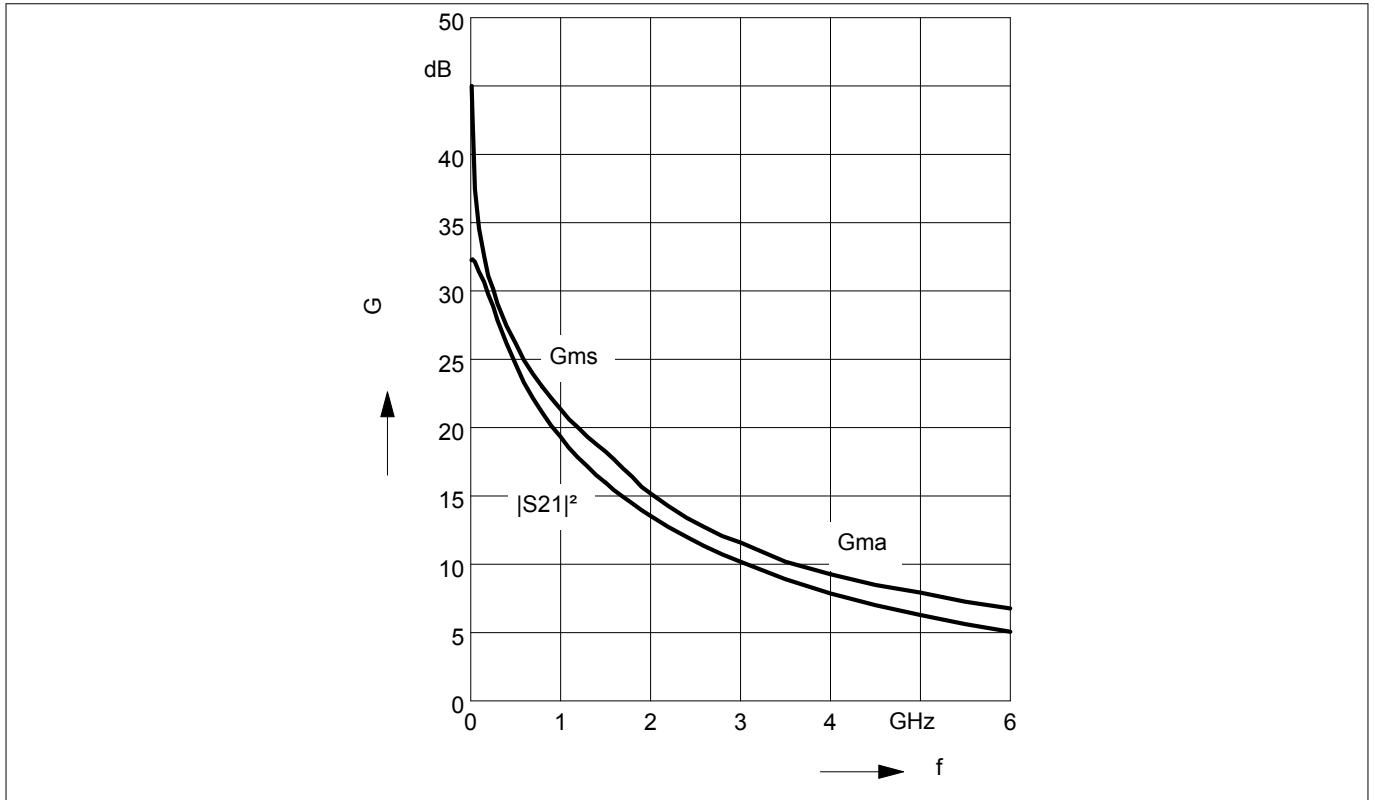


Figure 5 Gain G_{ma} , G_{ms} , $|S_{21}|^2 = f(f)$, $V_{CE} = 3\text{ V}$, $I_C = 20\text{ mA}$

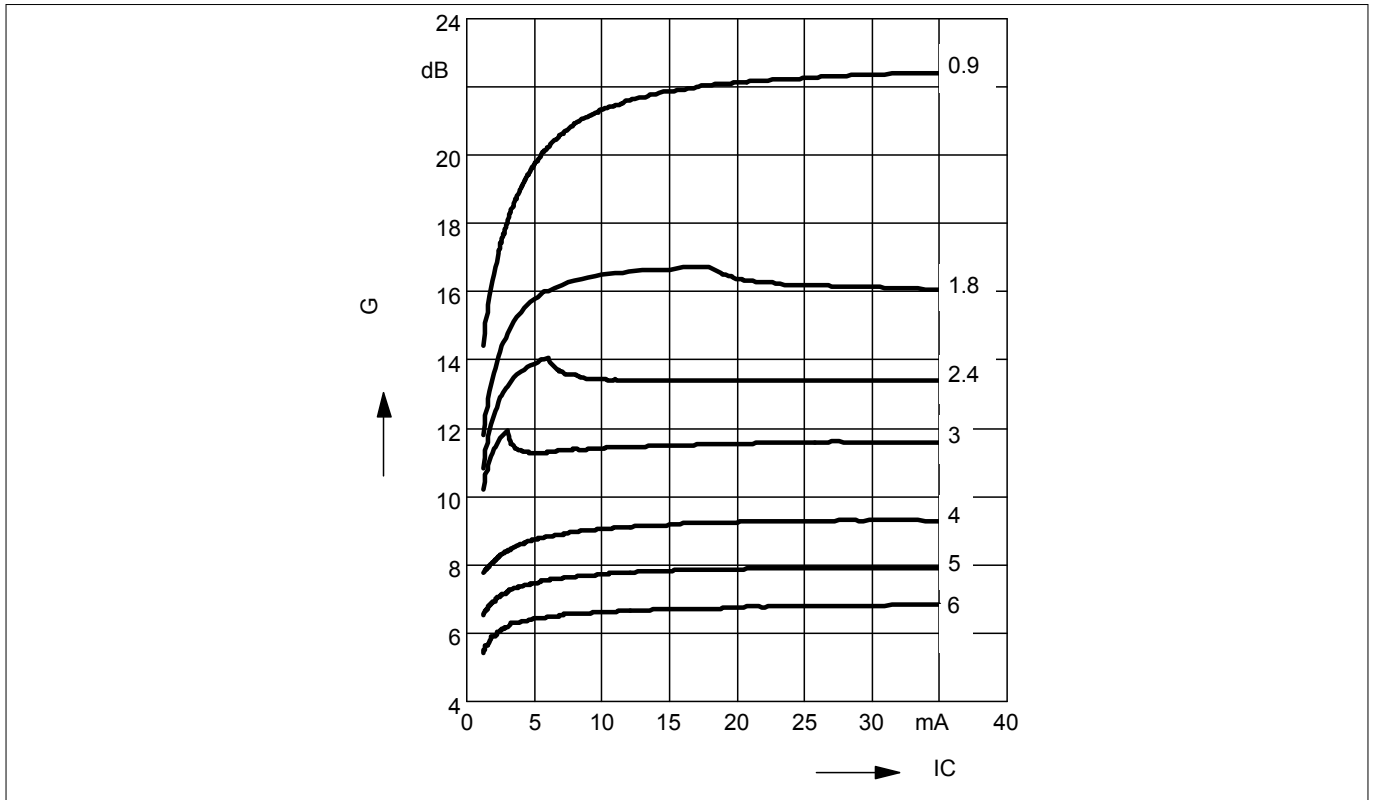


Figure 6 Maximum power gain $G_{max} = f(I_C)$, $V_{CE} = 3\text{ V}$, $f = \text{parameter in GHz}$

Electrical characteristics

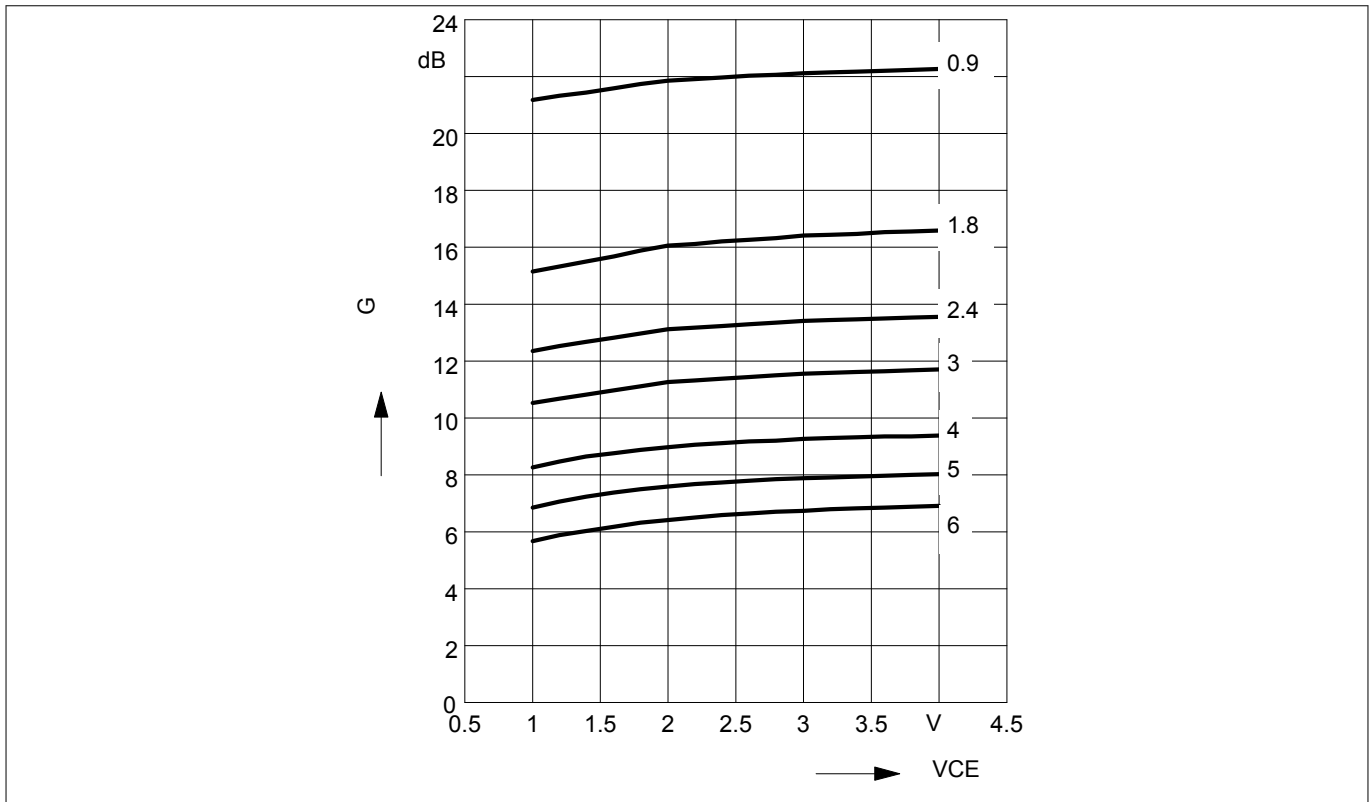


Figure 7 Maximum power gain $G_{max} = f(V_{CE}), I_C = 20 \text{ mA}, f = \text{parameter in GHz}$

Note: The curves shown in this chapter have been generated using typical devices but shall not be considered as a guarantee that all devices have identical characteristic curves. $T_A = 25 \text{ }^\circ\text{C}$.

Package information TSLP-3-1

4 Package information TSLP-3-1

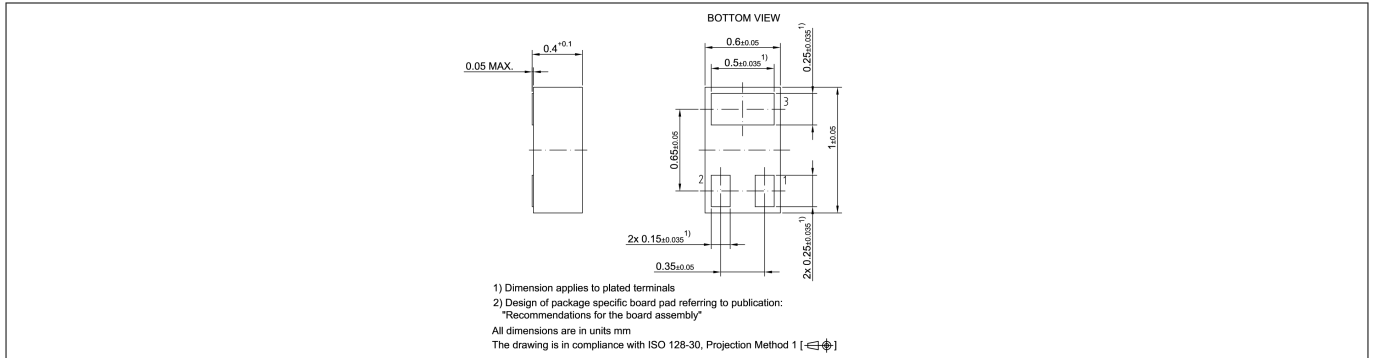


Figure 8 Package outline

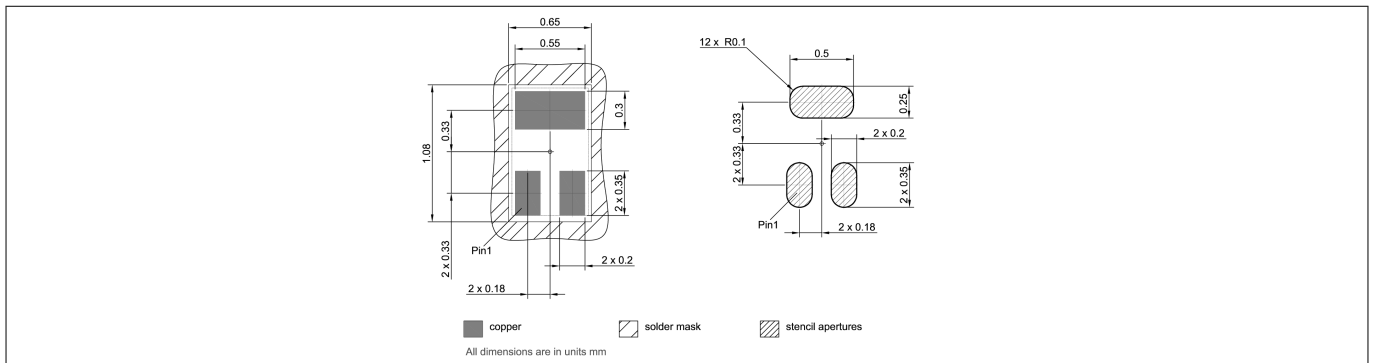


Figure 9 Foot print

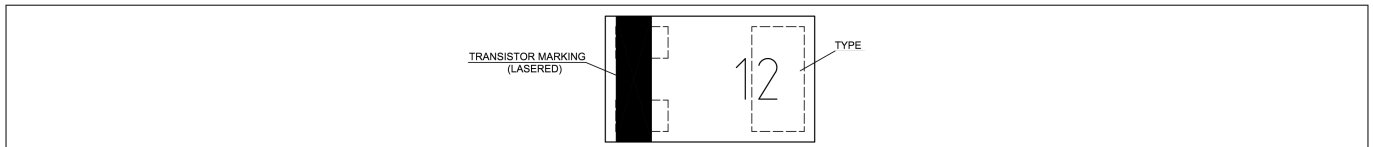


Figure 10 Marking layout example

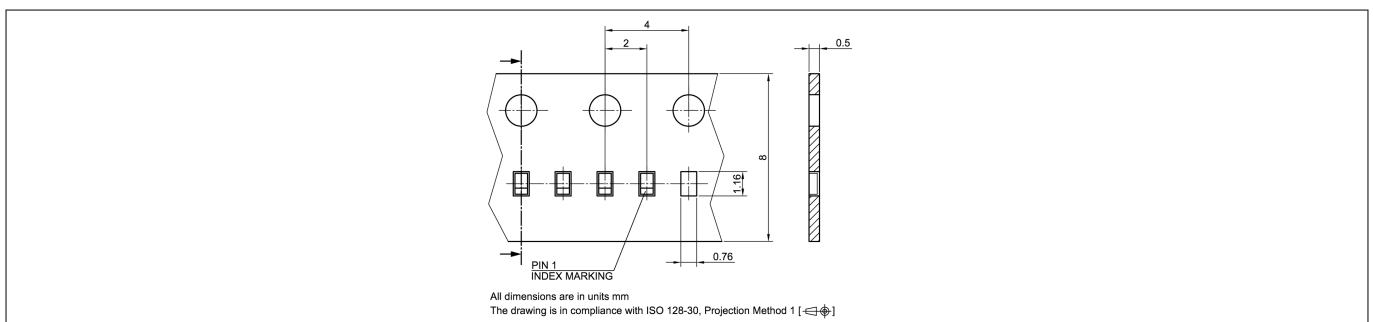


Figure 11 Tape information

Note: See our [Recommendations for Printed Circuit Board Assembly of TSLP/TSSLP/TSNP Packages](#). The marking layout is an example. For the real marking code refer to the device information on the first page. The number of characters shown in the layout example is not necessarily the real one. The marking layout can consist of less characters.

Revision history

Revision history

| Document version | Date of release | Description of changes |
|------------------|-----------------|------------------------|
| Revision 2.0 | 2019-01-25 | New datasheet layout. |

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Email: erratum@infineon.com

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